

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/824,434 YOON ET AL.	
		Examiner	Art Unit ALVIN H. TAN	2173 Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0046557	03-2003	Miller et al.	713/186
*	B	US-7,080,323	07-2006	Knott et al.	715/747
*	C	US-7,069,345	06-2006	Shteyn, Yevgeniy Eugene	709/250
*	D	US-6,934,915	08-2005	Rudd et al.	715/765
*	E	US-5,814,798	09-1998	Zancho, William F.	235/380
*	F	US-5,428,730	06-1995	Baker et al.	715/740
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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